

J348-VB Datasheet P-Channel 60-V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS}	-60	٧			
$R_{DS(on)} V_{GS} = 10 V$	19	mΩ			
$R_{DS(on)}$ $V_{GS} = 4.5 \text{ V}$	26	mΩ			
I _D	-50	Α			
Configuration	Single				

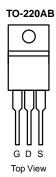
FEATURES

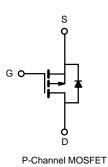
- Trench Power MOSFET100 % UIS Tested

APPLICATIONS

Load Switch







Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V _{DS}	- 60	V	
Gate-Source Voltage		V_{GS}	± 20		
Continuous Drain Current (T _J = 150 °C)	T _C = 25 °C		- 50		
	T _C = 70 °C	, –	- 46	А	
	T _A = 25 °C	I _D	-39		
	T _A = 70 °C		-34		
Pulsed Drain Current		I _{DM}	- 200		
Avalanche Current Pulse	1 0411	I _{AS}	- 45		
Single Pulse Avalanche Energy	L = 0.1 mH	E _{AS}	101	mJ	
Continuous Source-Drain Diode Current	T _C = 25 °C	,	69 ^a	^	
	T _A = 25 °C	I _S	20 ^b	Α	
Maximum Power Dissipation	T _C = 25 °C		104.2 ^a		
	T _C = 70 °C	Б	66.7 ^a	147	
	T _A = 25 °C	P _D	3.1 ^b	W	
	T _A = 70 °C		2 ^b	1	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150	°C	

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^b	Steady State	R_{thJA}	33	40	°C/W	
Maximum Junction-to-Case	Steady State	R_{thJC}	0.98	1.2	- C/W	

- a. Based on T_C = 25 °C.
 b. Surface mounted on 1" x 1" FR4 board.



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	- 60			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = - 250 μA		68		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	1 _D = - 250 μΛ		- 5.2			
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	- 1		- 3	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zana Cata Valta da Brain Commant		V _{DS} = - 60 V, V _{GS} = 0 V			- 1	^	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = - 60 V, V _{GS} = 0 V, T _J = 55 °C			- 10	μΑ	
On-State Drain Current ^a	I _{D(on)}	V _{DS} = - 5 V, V _{GS} = - 10 V	- 120			Α	
	В	V _{GS} = - 10 V, I _D = - 30 A		19		m-0	
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = - 4.5 V, I _D = - 20 A		26		mΩ	
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 15 V, I _D = - 50 A	20			S	
Dynamic ^b				L	L		
Input Capacitance	C _{iss}			3700			
Output Capacitance	C _{oss}	V _{DS} = - 25 V, V _{GS} = 0 V, f = 1 MHz		390		pF	
Reverse Transfer Capacitance	C _{rss}			290			
		V _{DS} = - 30 V, V _{GS} = - 10 V, I _D = - 55 A		76	115		
Total Gate Charge	Qg			38	60	1	
Gate-Source Charge	Q_{gs}	V _{DS} = - 30 V, V _{GS} = - 4.5 V, I _D = - 55 A		16		nC	
Gate-Drain Charge	Q_{gd}			19			
Gate Resistance	R_{g}	f = 1 MHz		5.2		Ω	
Turn-On Delay Time	t _{d(on)}			10	15		
Rise Time	t _r	$V_{DD} = -2 \text{ V}, R_L = 2 \Omega$		7	15		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong$ - 10 A, V_{GEN} = - 10 V, R_g = 1 Ω		70	110	ns ns	
Fall Time	t _f			40	60		
Drain-Source Body Diode Characteristics	S			l.	l		
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			- 69	_	
Pulse Diode Forward Current ^a	I _{SM}				- 150	A	
Body Diode Voltage	V _{SD}	I _S = - 30 A		- 1	- 1.5	V	
Body Diode Reverse Recovery Time	t _{rr}			45	68	ns	
Body Diode Reverse Recovery Charge	Q _{rr}			59	120	nC	
Reverse Recovery Fall Time	t _a	$I_F = -50 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 °C$		29			
Reverse Recovery Rise Time	t _b			16		ns	

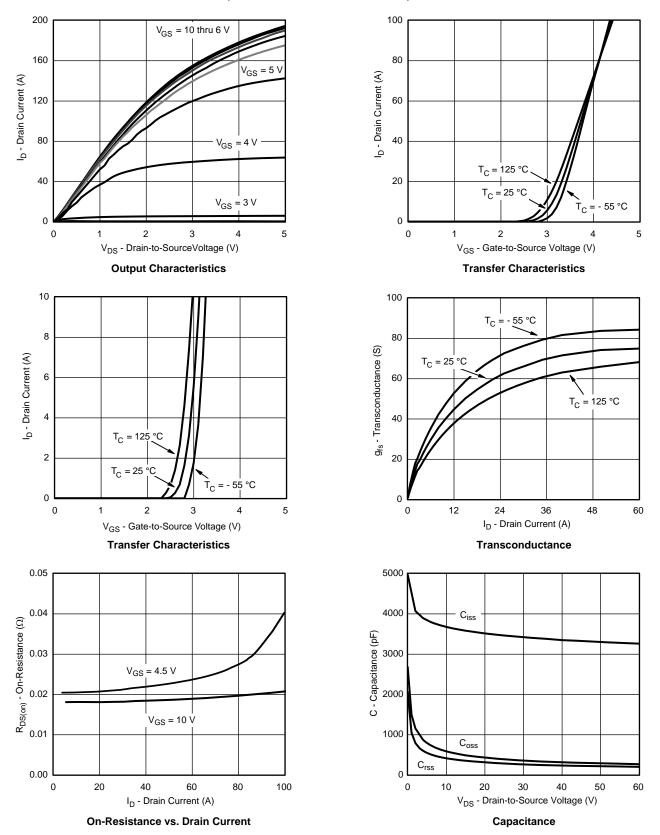
Notes:

- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

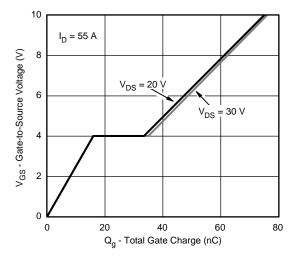


TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

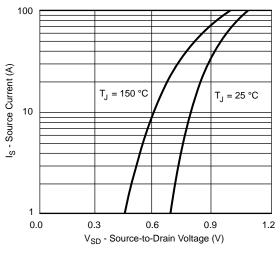




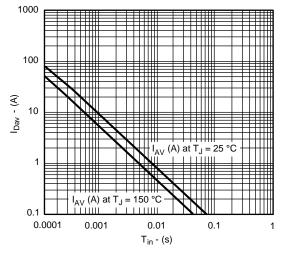
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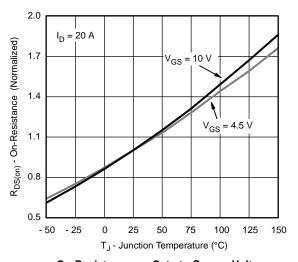
Gate Charge



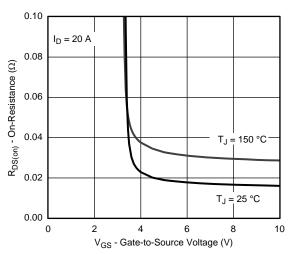
Source-Drain Diode Forward Voltage



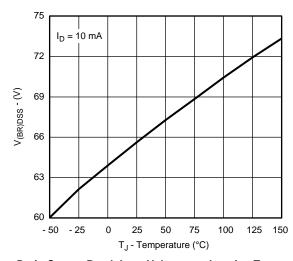
Single Pulse Avalanche Current Capability vs. Time



On-Resistance vs. Gate-to-Source Voltage



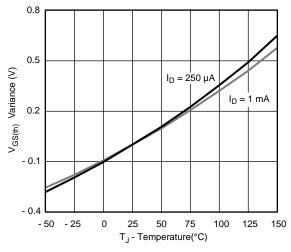
On-Resistance vs. Gate-to-Source Voltage

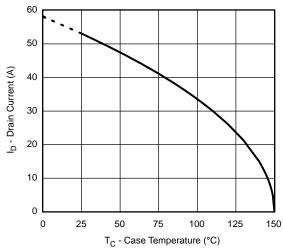


Drain-Source Breakdown Voltage vs. Junction Temperature

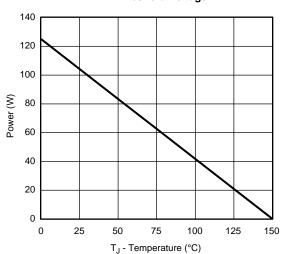


TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

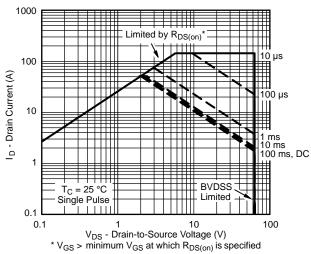




Threshold Voltage

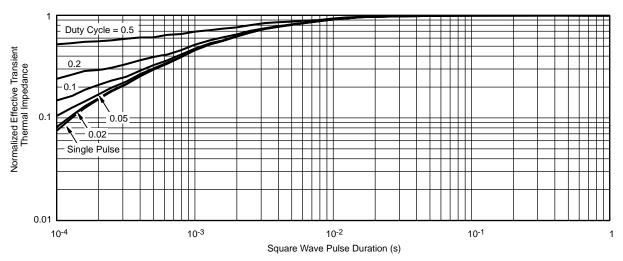


Max. Drain Current vs. Case Temperature



Power Derating, Junction-to-Case

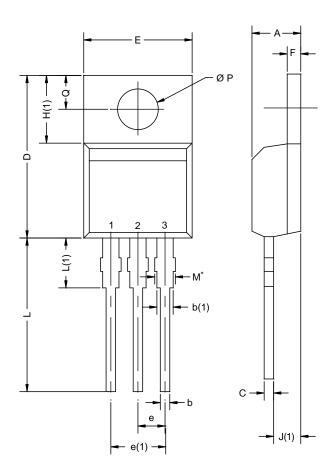




Normalized Thermal Transient Impedance, Junction-to-Case



TO-220AB



	MILLIM	IETERS	INCHES		
DIM.	MIN.	MAX.	MIN.	MAX.	
Α	4.25	4.65	0.167	0.183	
b	0.69	1.01	0.027	0.040	
b(1)	1.20	1.73	0.047	0.068	
С	0.36	0.61	0.014	0.024	
D	14.85	15.49	0.585	0.610	
E	10.04	10.51	0.395	0.414	
е	2.41	2.67	0.095	0.105	
e(1)	4.88	5.28	0.192	0.208	
F	1.14	1.40	0.045	0.055	
H(1)	6.09	6.48	0.240	0.255	
J(1)	2.41	2.92	0.095	0.115	
L	13.35	14.02	0.526	0.552	
L(1)	3.32	3.82	0.131	0.150	
ØΡ	3.54	3.94	0.139	0.155	
Q	2.60	3.00	0.102	0.118	
ECN: X12-0208-Rev. N, 08-Oct-12 DWG: 5471					

Notes

 $^{^{\}star}$ M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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